

SiC MOSFET Power Module



V_{DS}	1200V
I_D	400A
$R_{DS(on)}$	3.3m Ω

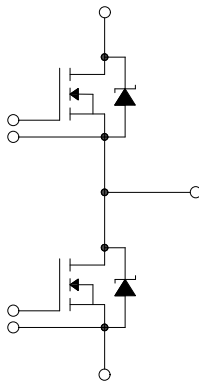
Applications

- Induction Heating
- Motor Drives
- Solar and Wind Inverters
- UPS and SMPS
- Traction

Features

- Industry Standard 62mm Footprint
- Ultra Low Loss, High-Frequency Operation
- Zero Reverse Recovery from Diodes
- Zero Turn-off Tail Current from MOSFET
- Normally-off, Fail-safe Device Operation
- Copper Baseplate and Si₃N₄-AMB Insulator (C2A)

Circuit



■ MOSFET

Absolute Maximum Ratings ($T_{VJ}=25^{\circ}\text{C}$ Unless Otherwise Specified)

PARAMETER	SYMBOL	CONDITIONS	VALUE	UNIT
Drain-Source Voltage	$V_{DS,max}$	$V_{GS}=0\text{ V}$, $I_{DS}=400\mu\text{A}$	1200	V
Continuous Drain Current	I_D	$V_{GS}=18\text{V}$, $T_C=25^{\circ}\text{C}$	400	A
		$V_{GS}=18\text{V}$, $T_C=80^{\circ}\text{C}$	315	
Pulse Drain Current	$I_{D,pulse}$	Pulse width t_p limited by $T_{VJ,max}$	630	A
Power Dissipation	$P_{D,MOS}$	$T_C=25^{\circ}\text{C}$	1120	W
Recommend Gate Source Voltage	$V_{GS,op}$	Static, recommended DC operating values	-5/18	V
Maximum Gate Source Voltage	$V_{GS,max}$	Absolute maximum values	-10/22	V
Maximum Junction Temperature	$T_{VJ,max}$		175	$^{\circ}\text{C}$



MC040HF12C2A

■ MOSFET

Characteristic Values ($T_{VJ}=25^{\circ}\text{C}$ Unless Otherwise Specified)

PARAMETER	SYMBOL	CONDITIONS	VALUE			UNIT
			Min.	Typ.	Max.	
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=400\mu A$	1200			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=80mA$	2.0	2.7	4.0	V
		$V_{DS}=V_{GS}, I_D=80mA, T_{VJ}=175^{\circ}\text{C}$		2.0		
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=1200V, V_{GS}=0V$		23	400	μA
Gate-Source Leakage Current	I_{GSS}	$V_{DS}=0V, V_{GS}=18V$		1	400	nA
Drain-Source On-Resistance	$R_{DS(on)}$	$I_D=300A, V_{GS}=15V$		4.1	6	m Ω
		$I_D=300A, V_{GS}=18V$		3.3	5	
		$I_D=300A, V_{GS}=15V, T_{VJ}=175^{\circ}\text{C}$		5.6		
		$I_D=300A, V_{GS}=18V, T_{VJ}=175^{\circ}\text{C}$		5.3		
Transconductance	g_{fs}	$V_{DS}=20V, I_D=300A$		247.1		S
		$V_{DS}=20V, I_D=300A, T_{VJ}=175^{\circ}\text{C}$		239.3		
Internal Gate Resistance	$R_{G(int.)}$	$f=1MHz, V_{AC}=25mV$		4.98		Ω
Input Capacitance	C_{iss}	$V_{GS}=0V,$		16.86		nF
Output Capacitance	C_{oss}	$V_{DS}=800V,$		2.03		
Reverse Transfer Capacitance	C_{rss}	$f=100kHz,$ $V_{AC}=25mV$		0.11		
Gate to Source Charge	Q_{GS}	$V_{DD}=800V,$		184		nC
Gate to Drain Charge	Q_{GD}	$V_{GS}=-5/18V,$		400		
Total Gate Charge	Q_G	$I_D=300A$		864		
Turn On Delay Time	$t_{d(on)}$	$V_{DD}=600V,$ $V_{GS}=-5/18V,$ $I_D=300A,$ $R_{G(ext)}=5.1\Omega$		96		ns
Rise Time	t_r			60		
Turn Off Delay Time	$t_{d(off)}$			448		
Fall Time	t_f			72		
Turn-on Switching Energy, $T_{VJ}=25^{\circ}\text{C}$ $T_{VJ}=150^{\circ}\text{C}$	E_{on}			9.99 8.34		mJ
Turn-off Switching Energy, $T_{VJ}=25^{\circ}\text{C}$ $T_{VJ}=150^{\circ}\text{C}$	E_{off}			16.31 16.74		
MOSFET Thermal Resistance, Junction to Case	R_{thJC}	JESD51-14		0.134		$^{\circ}\text{C/W}$



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■ Body diode

Characteristic Values ($T_{VJ}=25^{\circ}\text{C}$ Unless Otherwise Specified)

PARAMETER	SYMBOL	CONDITIONS	VALUE			UNIT
			Min.	Typ.	Max.	
Inverse Diode Forward Voltage	V_{SD}	$V_{GS}=-5\text{V}$, $I_S=300\text{A}$		1.51		V
		$V_{GS}=-5\text{V}$, $I_S=300\text{A}$, $T_{VJ}=175^{\circ}\text{C}$		2.2		
Continuous Diode Forward Current	I_S	$V_{GS}=-5\text{V}$, $T_C=25^{\circ}\text{C}$			430	A
Reverse Recovery Time	t_{rr}	$V_{GS}=-5\text{V}$, $I_S=300\text{A}$, $V_R=600\text{V}$, $di/dt=4.63\text{A/ns}$, $T_{VJ}=150^{\circ}\text{C}$		46		ns
Reverse Recovery Charge	Q_{rr}			3.87		uC
Peak Reverse Recovery Current	I_{rrm}			142.6		A
Reverse Recovery Energy, $T_{VJ}=25^{\circ}\text{C}$ $T_{VJ}=150^{\circ}\text{C}$	E_{RR}	$V_{DD}=600\text{V}$, $I_D=300\text{A}$ $V_{GS}=-5\text{V}/18\text{V}$, $R_{G(\text{ext})}=5.1\Omega$		0.83 1.01		mJ

■ Module Characteristics

PARAMETER	SYMBOL	CONDITIONS	VALUE			UNIT
			Min.	Typ.	Max.	
Isolation Breakdown Voltage	V_{isol}	AC, 50Hz (R.M.S), $t=1\text{minute}$		4000		V
Stray Inductance	L_{Stray}	Between DC- and DC+, $f=10\text{MHz}$		12		nH
Operating Junction Temperature	$T_{VJ,op}$		-40		175	$^{\circ}\text{C}$
Storage Temperature	T_{stg}		-40		150	$^{\circ}\text{C}$
Module Electrodes Torque	M_t	Recommended (M6)	3.0		5.0	Nm
Module to Sink Torque	M_s	Recommended (M6)	3.0		5.0	Nm
Weight	W			315		g



■ Typical Performance

Fig1. Output Characteristics for Various Junction Temperatures

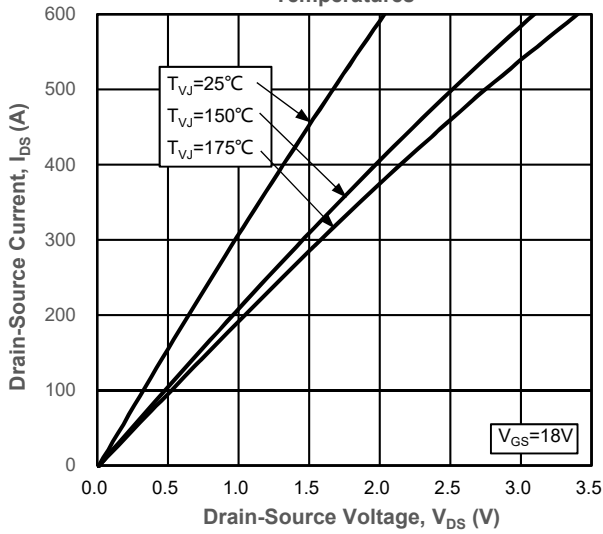


Fig2. Output Characteristics for Various Junction Temperatures

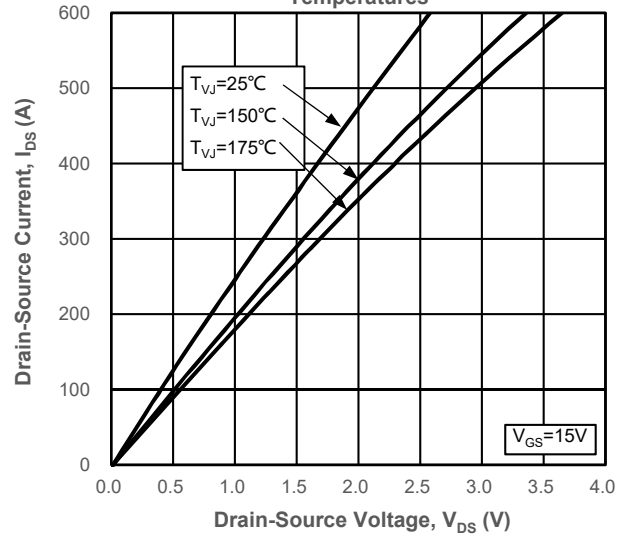


Fig3. Normalized On-State Resistance vs. Drain Current for Various Junction Temperatures

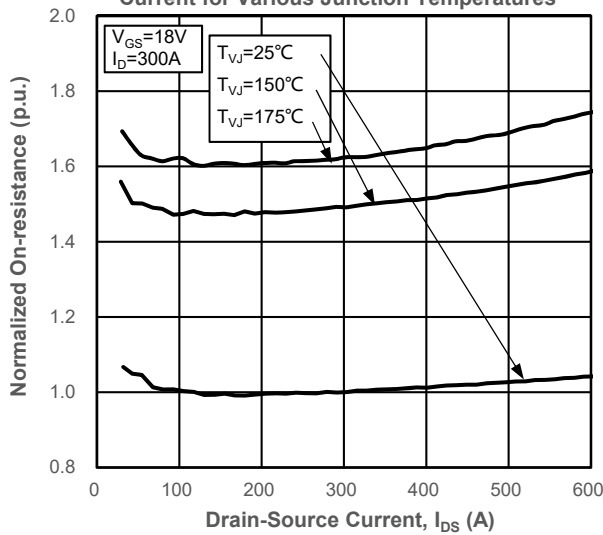


Fig4. Normalized On-State Resistance vs. Drain Current for Various Junction Temperatures

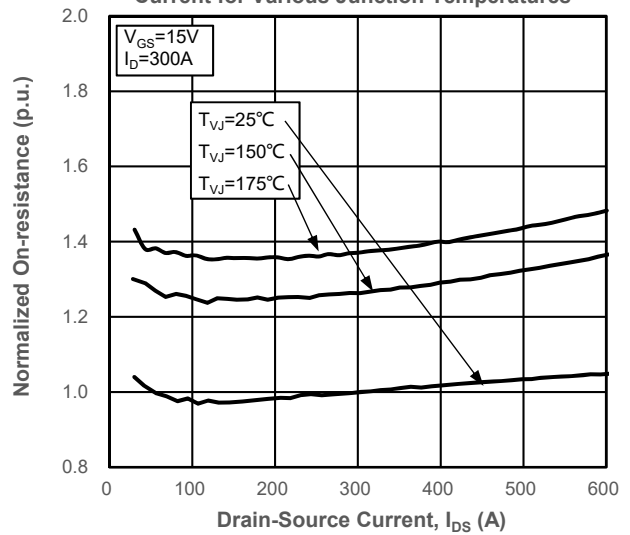


Fig5. Transfer Characteristic for Various Junction Temperatures

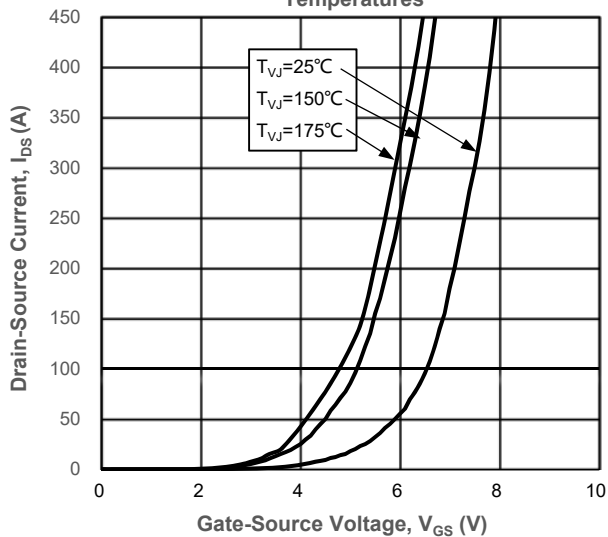


Fig6. 3rd Quadrant Characteristic vs. Junction Temperatures at $V_{GS} = 18V$

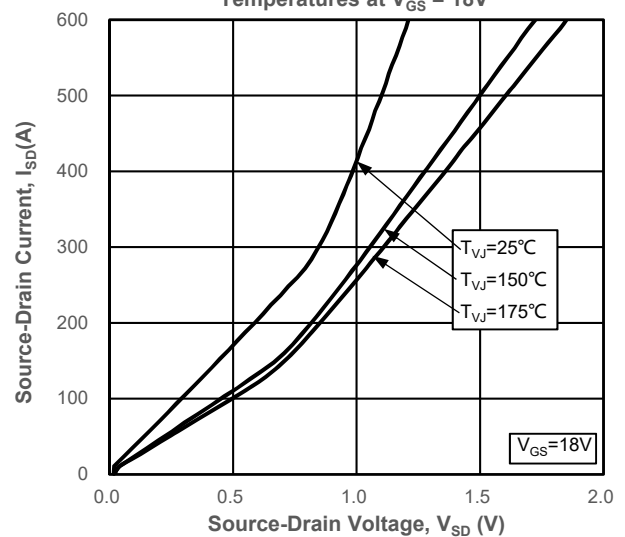




Fig7. 3rd Quadrant Characteristic vs. Junction Temperatures at $V_{GS}=0V$

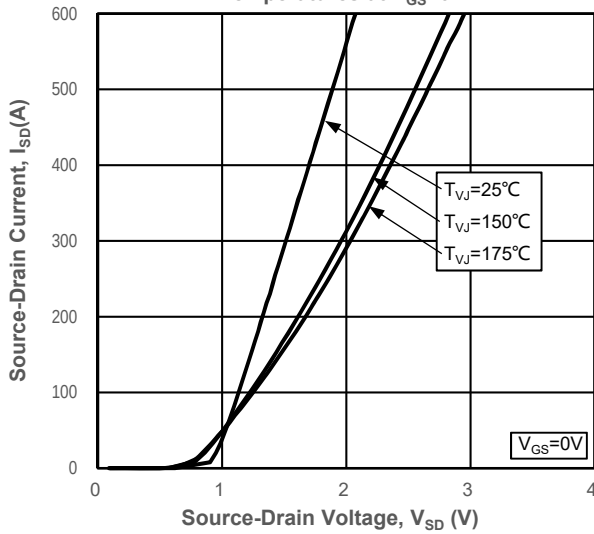


Fig8. 3rd Quadrant Characteristic vs. Junction Temperatures at $V_{GS}=-5V$

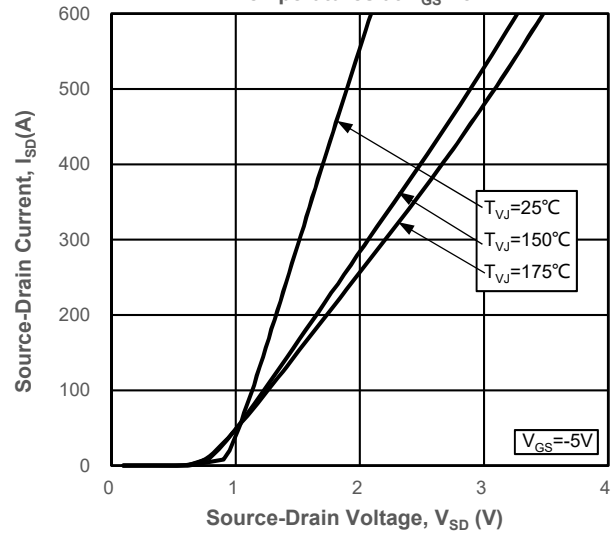


Fig9. Typical Capacitances vs. Drain to Source Voltage (0-200V)

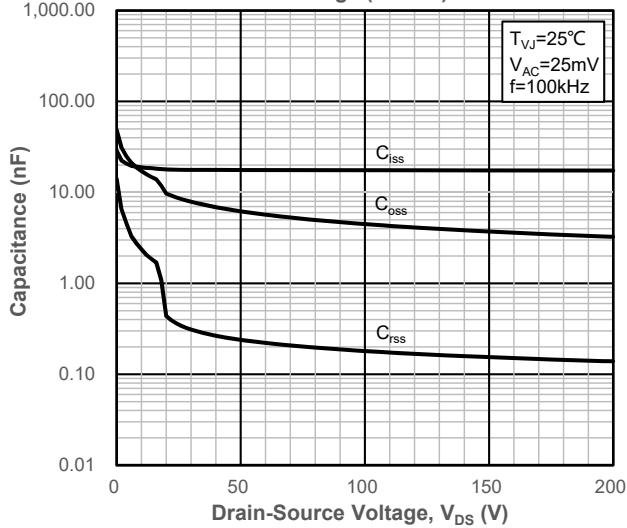


Fig10. Typical Capacitances vs. Drain to Source Voltage (0-1200V)

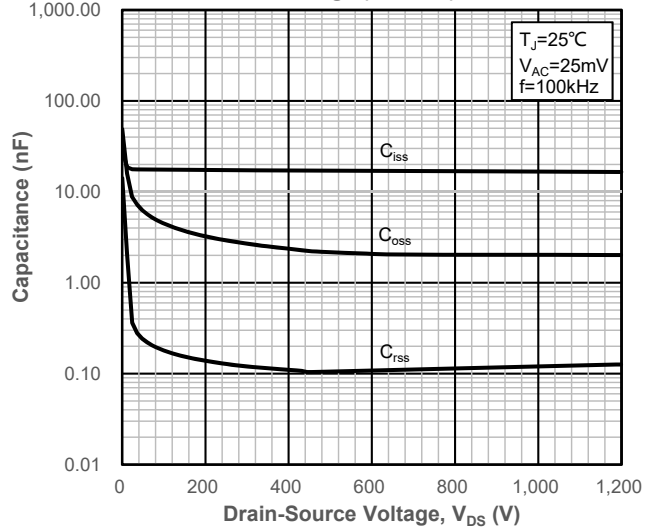


Fig11. Switching Energy vs. Drain Current ($V_{DD}=600V$)

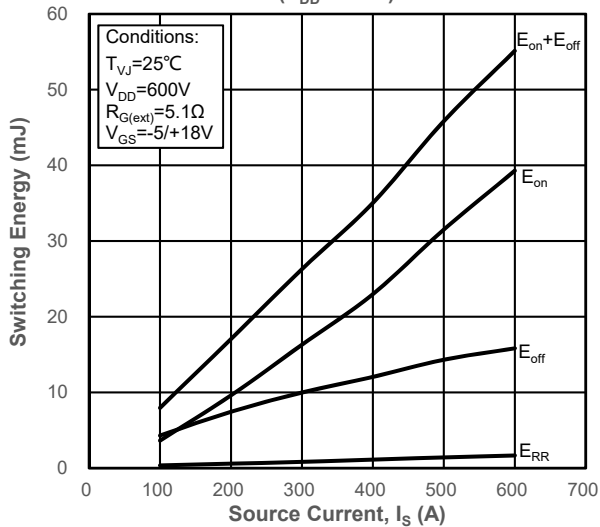
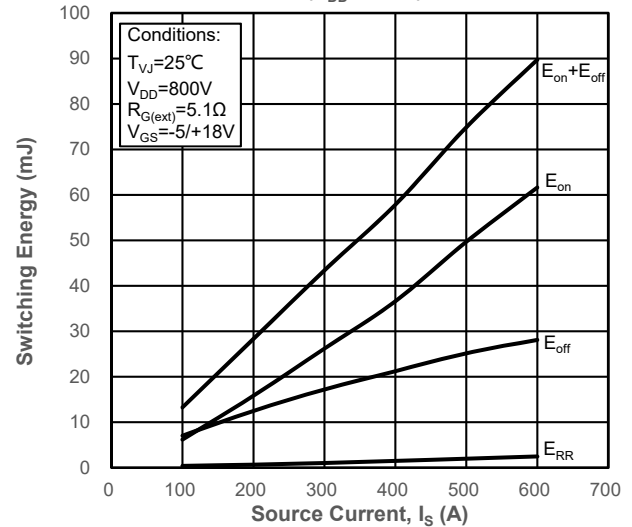


Fig12. Switching Energy vs. Drain Current ($V_{DD}=800V$)





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Fig13. MOSFET Switching Energy vs. External Gate Resistance

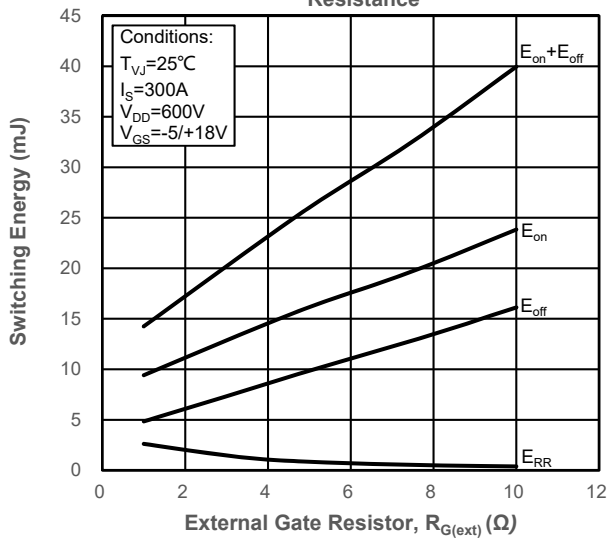


Fig14. Reverse Recovery Energy vs. External Gate Resistance

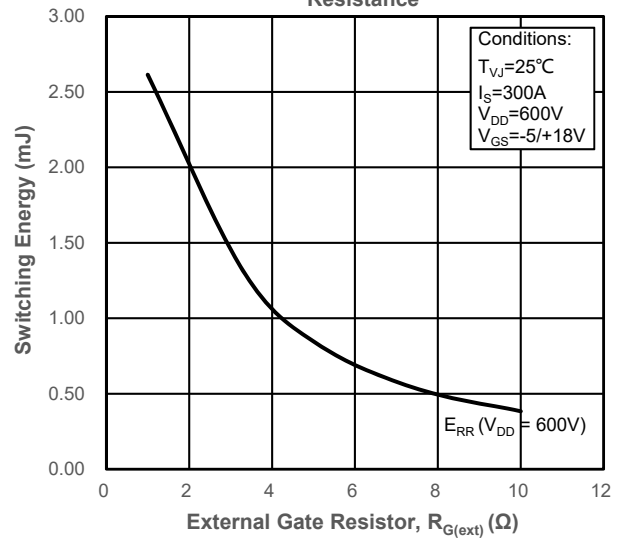


Fig15. MOSFET Junction to Case Transient Thermal Impedance, Z_{thJC} ($^{\circ}\text{C/W}$)

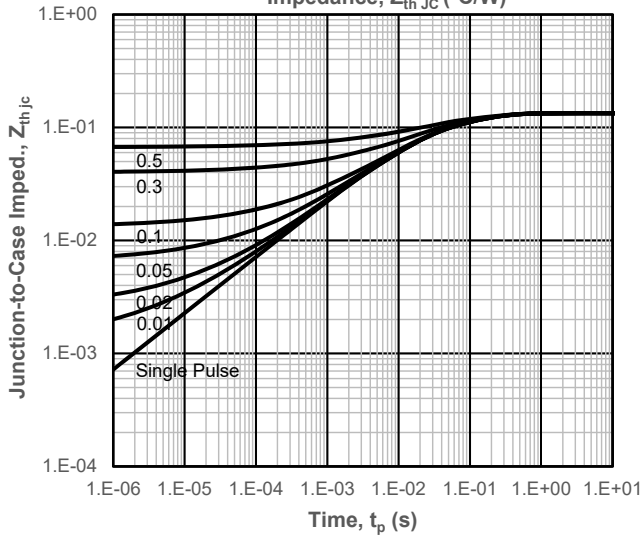


Fig16. Diode Junction to Case Transient Thermal Impedance, Z_{thJC} ($^{\circ}\text{C/W}$)

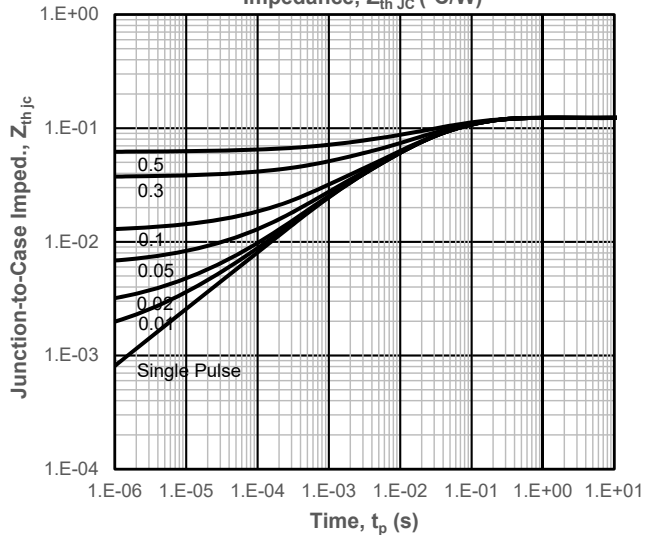


Fig17. Forward Bias Safe Operating Area (FBSOA)

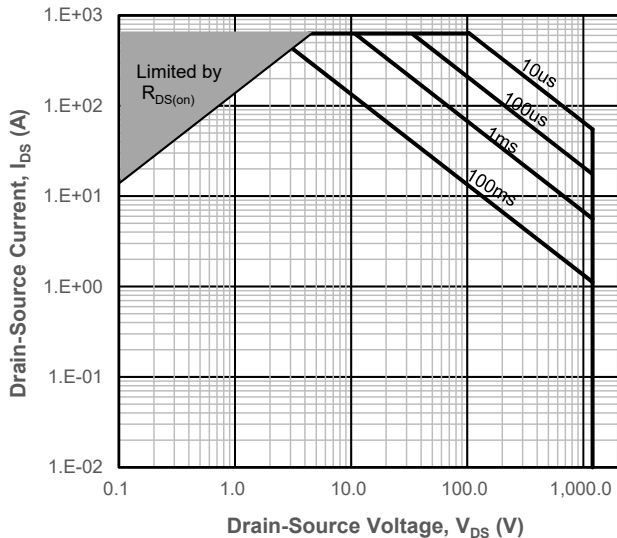
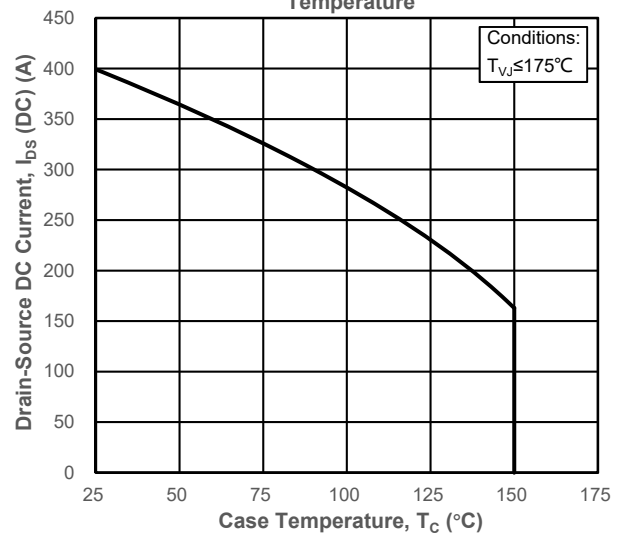


Fig18. Continuous Drain Current Derating vs. Case Temperature





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Fig19. Maximum Power Dissipation Derating vs. Case Temperature

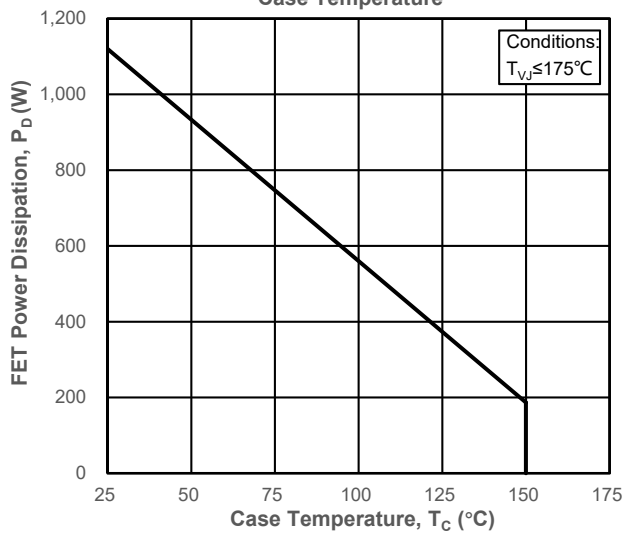


Fig20. Timing vs. Source Current

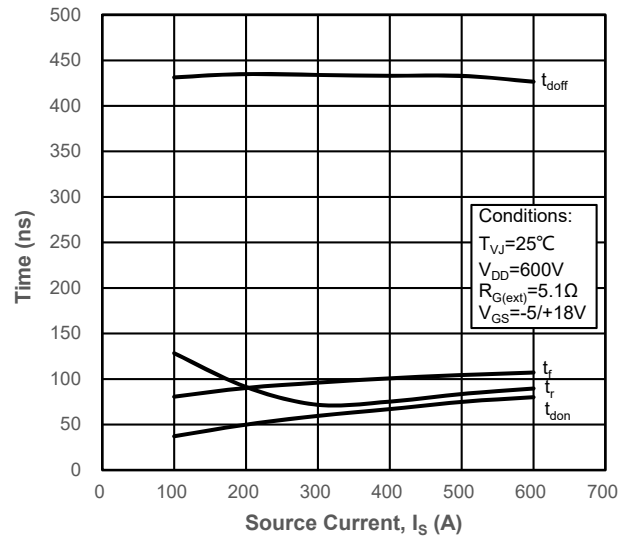


Fig21. dv/dt and di/dt vs. Source Current

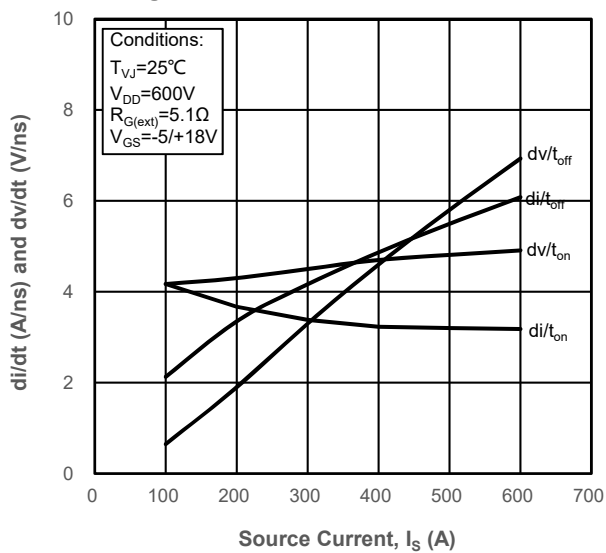


Fig22. Timing vs. External Gate Resistance

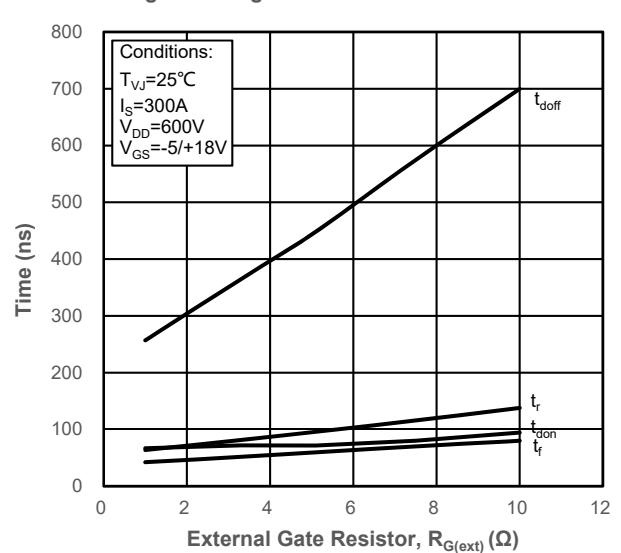
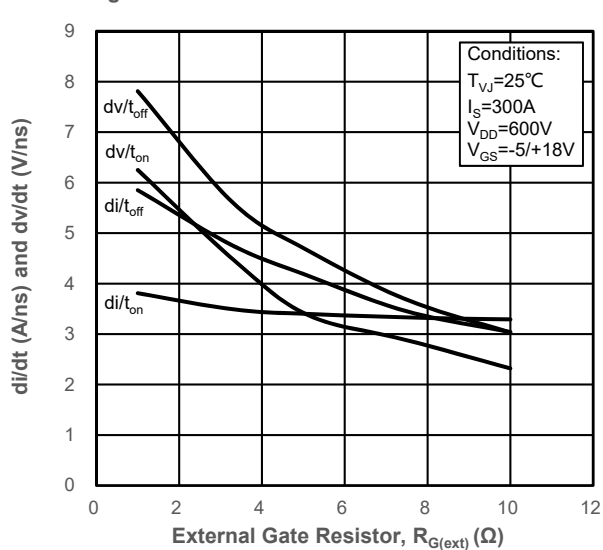


Fig23. dv/dt and di/dt vs. External Gate Resistance



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